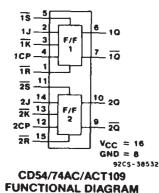


### CD54/74AC109, CD54/74AC112 CD54/74ACT109, CD54/74ACT112

Data sheet acquired from Harris Semiconductor SCHS282



## Dual "J-K" Flip-Flop with Set and Reset

CD54/74AC/ACT109 - Positive-Edge-Triggered (J,  $\overline{K}$ ) CD54/74AC/ACT112 - Negative-Edge-Triggered (J, K)

#### **Type Features:**



Typical propagation delay:
 4.8 ns @ V<sub>cc</sub> = 5 V, T<sub>A</sub> = 25° C, C<sub>L</sub> = 50 pF

The RCA CD54/74AC109 and CD54/74AC112 and the CD54/74ACT109 and CD54/74ACT112 dual "J-K" flip-flops with set and reset use the RCA ADVANCED CMOS technology. These flip-flops have independent J, K (or K), Set, Reset, and Clock inputs and Q and  $\overline{Q}$  outputs. The CD54/74AC/ACT112 changes state on the negative-going transition of the clock pulse. The CD54/74AC/ACT109 changes state on the positive-going transition of the clock. Set and Reset are accomplished asynchronously by low-level inputs.

The CD74AC/ACT109 and CD74AC/ACT112 are supplied in 16-lead dual-in-line plastic packages (E suffix) and in 16lead dual-in-line small-outline plastic packages (M suffix). Both package types are operable over the following temperature ranges: Commercial (0 to 70°C); Industrial (-40 to +85°C); and Extended Industrial/Military (-55 to +125°C).

The CD54AC/ACT109 and CD54AC/ACT112, available in chip form (H suffix), are operable over the -55 to +125°C temperature range.

#### **Family Features:**

- Exceeds 2-kV ESD Protection MIL-STD-883, Method 3015
- SCR-Latchup-resistant CMOS process and circuit design
  Speed of bipolar FAST\*/AS/S with significantly
- reduced power consumption
- Balanced propagation delays

AC types feature 1.5-V to 5.5-V operation and balanced noise immunity at 30% of the supply

£ 24-mA output drive current Fanout to 15 FAST\* ICs Drives 50-ohm transmission lines

\*FAST is a Registered Trademark of Fairchild Semiconductor Corp.

<u> </u>		INPUTS			1	
		OUTPUTS				
Ŝ	R	СР	J	ĸ	Q	ā
L	н	x	x	x	н	L
н	L	х	x	х	L	н
L	L	×	x	х	H.	н.
н	н	_/_	L	L	ί ι	н
н	н		н	L	TOG	GLE
н	н		L	н	NO CH	ANGE
н	н		н	н	н	Ľ
н	н	L	x	x	NO CH	IANGE

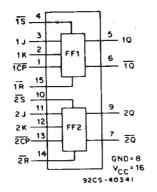
#### CD54/74AC/ACT109 TRUTH TABLE

\*Unpredictable and unstable condition if both  $\overline{S}$  and  $\widetilde{R}$  go high simultaneously.

This data sheet is applicable to the CD54/74AC109, CD54AC112, CD45ACT109, and CD54ACT112. See SCHS233 for information on the CD74AC112, CD74ACT109, and CD74ACT112.

File Number 1967

#### Technical Data \_\_\_\_\_\_ CD54/74AC109, CD54/74AC112 CD54/74ACT109, CD54/74ACT112



		OUTPUTS				
s	R	ĈP	J	к	Q	ā
L	н	x	x	x	н	L
⊢н	L,	<sup>v</sup> <b>x</b>	x	x	L	н
L	L	Χ.	х	x	. н <b>.</b>	H.
н	н	- <b>_</b>	L	L	NO CH	IANGE
н	́н	_٦	н	L	н	L
н	н	_٦_	L	н	L	н
н	н	_۲_	н	н	TOG	IGLE
н	н	н	X	x	NO CH	IANGE

#### CD54/74AC/ACT112 TRUTH TABLE

\*Output states unpredictable if  $\overline{S}$  and  $\overline{R}$  go High simultaneously after both being Low at the same time.

- 10

H = High steady state

L = Low steady state X = Irrelevant

 $n_{--}$  = High-to-Low transition

CD54/74AC/ACT112 FUNCTIONAL DIAGRAM

MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE (V <sub>cc</sub> )	
DC INPUT DIODE CURRENT. In (for $V_1 \le -0.5$ V or $V_1 \ge V_{cc} + 0.5$ V)	
DC OUTPUT DIODE CURRENT. Inv (for $V_0 < -0.5$ V or $V_0 > V_{cc} + 0.5$ V)	
DC OUTPUT SOURCE OR SINK CURRENT per Output Pin, Io (for Vo > -0.5 V	$V \text{ or } V_0 < V_{CC} + 0.5 \text{ V}$ ±50 mA
DC Vcc or GROUND CURRENT (Icc or IGND)	
POWER DISSIPATION PER PACKAGE (PD):	
POWER DISSIPATION PER PACKAGE (P <sub>D</sub> ): For $T_A = -55$ to $\pm 100^{\circ}$ C (PACKAGE TYPE E)	
For $T_A = +100$ to $+125^{\circ}$ C (PACKAGE TYPE E)	Derate Linearly at 8 mW/°C to 300 mW
For $T_{A} = -55$ to $\pm 70^{\circ}$ C (PACKAGE TYPE M)	
For $T_A = +70$ to $\pm 125^{\circ}$ C (PACKAGE TYPE M)	Derate Linearly at 6 mw/°C to 70 mw
OPERATING_TEMPERATURE BANGE (T_)	
STORAGE TEMPERATURE (T <sub>stg</sub> )	65 to +150°C
I EAD TEMPERATURE (DURING SOLDERING)	
At distance 1/16 $\pm$ 1/32 in. (1.59 $\pm$ 0.79 mm) from case for 10 s maximum .	+265°C
Unit inserted into PC board min. thickness 1/16 in. (1.59 mm) with solder co	ontacting lead tips only +300°C

\*For up to 4 outputs per device; add ± 25 mA for each additional output.

#### **RECOMMENDED OPERATING CONDITIONS:**

For maximum reliability, normal operating conditions should be selected so that operation is always within the following ranges:

	LIM	LIMITS			
CHARACTERISTICS	MIN.	MAX.	UNITS		
Supply-Voltage Range, V <sub>CC</sub> *: (For T <sub>A</sub> = Full Package-Temperature Range) AC Types ACT Types	1.5 4.5	5.5 5.5	v v		
DC Input or Output Voltage, V <sub>1</sub> , V <sub>0</sub>	0	Vcc	V		
Operating Temperature, TA	-55	+125	°C		
Input Rise and Fall Slew Rate, dt/dv at 1.5 V to 3 V (AC Types) at 3.6 V to 5.5 V (AC Types) at 4.5 V to 5.5 V (ACT Types)	0 0 0	50 20 10	ns/V ns/V ns/V		

\*Unless otherwise specified, all voltages are referenced to ground

\* **Technical Data** 

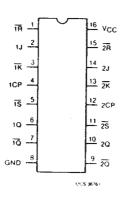
# CD54/74AC109, CD54/74AC112 CD54/74ACT109, CD54/74ACT112

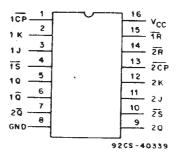
#### STATIC ELECTRICAL CHARACTERISTICS: AC Series

						AMBIEN	Т ТЕМРЕ	ERATURI	E (T <sub>A</sub> ) - °	С	
CHARACTERISTICS		TEST CONDITIONS		v <sub>cc</sub>	+	+25		-40 to +85		-55 to +125	
		V, (V)	l <sub>o</sub> (mA)	<b>(∀)</b> ( 	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	1
High-Level Input Voltage	Vн			1.5 3 5.5	1.2 2.1 3.85	-	1.2 2.1 3.85		1.2 2.1 3.85		v
Low-Level Input Voltage	Vit			1.5 3 5.5		0.3 0.9 1.65		0.3 0.9 1.65		0.3 0.9 1.65	v
High-Level Output			-0.05	1.5	1.4		1.4	_	1.4	<u> </u>	1
Voltage V <sub>OH</sub>	V <sub>он</sub>	VIH	-0.05	3	2.9		2.9		2.9		1
	or	-0.05	4.5	4.4	-	4.4		4.4		1	
		ViL	-4	3	2.58		2.48		2.4		1 v
			-24	4.5	3.94	_	3.8	_	3.7		1
		#, * {	-75	5.5	_	-	3.85			_	1
		<i>"</i> , ``	-50	5.5	_	-			3.85	—	1
Low-Level Output			0.05	1.5	_	0.1	3-15	0.1	_	0.1	
Voltage	Vol	· ViH	0.05	3	—	0.1		0.1	_	0.1	
		or	0.05	4.5	- 4	0.1		0.1	_	0.1	
		VIL	12	3		0.36	1-	0.44	_	0.5	v
			24	4.5	-	0.36	_	0.44		0.5	
		#, * {	75	5.5		_	_	1.65	—	_	
		" <b>,</b> )	50	5.5		—	—	—	—	1.65	
Input Leakage Current	h	V <sub>cc</sub> or GND		5.5	_	±0.1	-	±1	—	±1	μA
Quiescent Supply Current, FF	Icc	V <sub>cc</sub> or GND	0	5.5	_	4	. —	40		80	μΑ

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation. \* Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

#### **TERMINAL ASSIGNMENT DIAGRAMS**





#### CD54/74AC/ACT109

#### CD54/74AC/ACT112

#### Technical Data \_\_\_\_

# CD54/74AC109, CD54/74AC112 CD54/74ACT109, CD54/74ACT112 STATIC ELECTRICAL CHARACTERISTICS: ACT Series

							Г ТЕМРЕ	RATURE	(T <sub>A</sub> ) - °0	C	
CHARACTERISTICS		TEST CON	DITIONS	Vcc	+	25	-40 to +85		-55 to +125		UNITS
		V, (V)	l <sub>o</sub> ∘ (mA)	(Ÿ)	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	1
High-Level Input Voltage	ViH			4.5 to 5.5	2	_	2		2	_	v
Low-Level Input Voltage	Vil		Addude # 84 - 80	4.5 to 5.5		0.8	_	0.8	_	0.8	v
High-Level Output		VIH	-0.05	4.5	4.4	-	4.4	-	4.4		
Voltage	V <sub>OH</sub> Or V <sub>IL</sub>	-24	4.5	3.94	-	3.8	-	3.7			
		(	-75	5.5	-		3.85	-	—	_	V
		#, * {	-50	5.5					3.85		
Low-Level Output		VIH	0.05	4.5	—	0.10		0.10	—	0.10	
Voltage	Vol	or Vil	24	4.5	_	0.36	—	0.44		0.50	v
		6	75	5.5	_	—		1.65	_	—	
		#, * {	50	5.5	—	-	÷.		_	1.65	
Input Leakage Current	1,	V <sub>cc</sub> or GND		5.5	-	±0.1	*-0	1±1	—	±1	μA
Quiescent Supply Current, FF	lcc	V <sub>cc</sub> or GND	0	5.5	-	CO	_	40	—	80	μA
Additional Supply Current per Input Pin TTL Inputs High 1 Unit Load	Δlcc	V <sub>cc</sub> -2.1	R	4.5 to 5.5	_	2.4	—	2.8		3	mA

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation. \* Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

#### ACT INPUT LOADING TABLE

INPUT	UNIT LOADS*					
INPUT	109	112				
J, CP, CP	1	1				
ĸ	—	0.53				
ĸ	0.53	-				
S, R	0.58	0.58				

\*Unit load is Alcc limit specified in Static Characteristics Chart, e.g., 2.4 mA max. @ 25°C.

\_ Technical Data

# CD54/74AC109, CD54/74AC112 CD54/74ACT109, CD54/74ACT112

#### **PREREQUISITE FOR SWITCHING: AC Series**

			AMBI	]			
CHARACTERISTICS	SYMBOL	V <sub>cc</sub> (V)	-40 t	o +85	-55 to	UNITS	
			MIN.	MAX.	MIN.	MAX.	1
Maximum CP, (CP) Frequency 109	f <sub>max</sub>	1.5 3.3* 5†	9 81 114		8 71 100	-	MHz
112	fmax	1.5 3.3 5	9 81 114		8 71 100		MHz
CP, (CP) Pulse Width	tw	1.5 3.3 5	55 6 4.4		63 7 5		ns
R, S Pulse Width	tw	1.5 3.3 5	49 5.5 3.9		56 6.3 4.5		ns
Setup Time J, K to CP 109	tsu	1.5 3.3 5	61 6.8 4.8		69 7.7 5.5		ns
J, K to ĈP 112	tsu	1.5 3.3 5	44 4.9 3.5	- Pr	50 5.6 4	-	ns
Hold Time J, K to CP 109	t <sub>H</sub>	1.5 3.3 5	0 0 0	T	0 0 0		ns
J, K to CP 112	tH	1.5 3.3 5			0 0 0	-	ns
Removal Time R, S to CP, (CP)	<b>L</b> REM	1.5 3.1 5	27 3.1 2.2		31 3.5 2.5		ns

\*3.3 V: min. is @ 3 V t5 V: min is @ 4.5 V

#### SWITCHING CHARACTERISTICS: AC Series; t, tr = 3 ns, CL = 50 pF

			AMBI	ENT TEMPE	RATURE (1	UNITS	
CHARACTERISTICS	SYMBOL	V <sub>cc</sub> (V)	-40 t	o +85	-55 to		
		(V)	MIN.	MAX.	MIN.	MAX.	
Propagation Delays: CP, (CP) to Q, Q	tрін tрні	1.5 3.3* 5†	 3.7 2.7	117 13.1 9.4	 3.6 2.6	129 14.4 10.3	ns
S. R to Q, Q	tрін tphl	1.5 3.3 5	 4.4 3.2	139 15.5 11.1	 4.3 ⋅ 3.1	153 17.1 12.2	ns
Power Dissipation Capacitance	CPD§	_	56	Тур.	56	Гур.	pF
Input Capacitance	Ci	_	_	10		10	pF

\*3.3 V: min. is @ 3.6 V max. is @ 3 V

† 5 V: min. is @ 5.5 V max. is @ 4.5 V

§CPD is used to determine the dynamic power consumption, per flip-flop.  $P_D = C_{PD}V_{CC}^2 f_i + \Sigma (C_L V_{CC}^2 f_o)$  where  $f_i = input$  frequency

 $f_o =$ output frequency  $C_L =$ output load capacitance

 $V_{cc}$  = supply voltage.

## Technical Data CD54/74AC109, CD54/74AC112 CD54/74ACT109, CD54/74ACT112

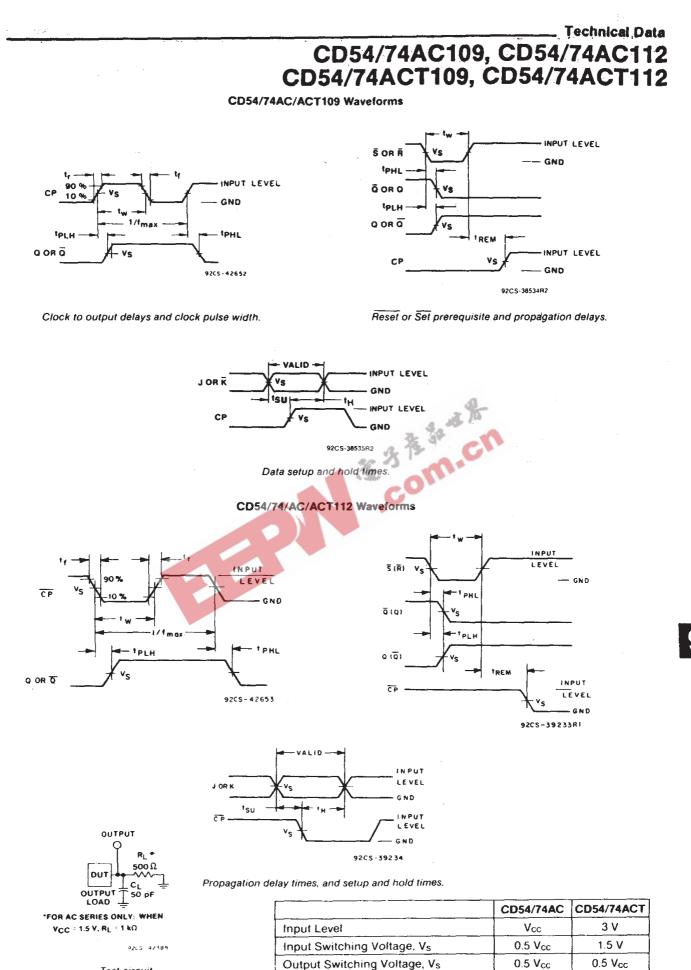
PREREQUISITE FOR SWITCHING: ACT Series

			AMBI	ENT TEMPE	RATURE (1	(∧) - °C	Τ
CHARACTERISTICS	SYMBOL	V <sub>cc</sub> (V)	-40 to +85		-55 to +125		UNITS
· _		(*)	MIN.	MAX.	MIN.	MAX.	
Maximum CP, (CP) Frequency 109	fmax	5*	114	_	100	_	MHz
112	tw	•	114	_	100	-	
CP, (CP) Pulse Width	tw	5	4.4	_	5	—	ns
R, S Pulse Width	tw	5	4.8		5.5		ns
Setup Time J, K to CP (109)	tsu	5	.4.8	· <u> </u>	5.5	_	ns
J, K to CP (112)			3.5		4		1
Hold Time J, K to CP (109)	tH	5 .	0	_	0	_	ns
J, K to CP (112)			1	_	1		1
Removal Time R, S to CP, (CP)	tREM	5	2.2		2.5		ns

#### SWITCHING CHARACTERISTICS: ACT Series; t,, t, = 3 ns, C, = 50 pF

*5 V: min. is @ 4.5 V	<b>Series; t,, t,</b> = 3	I ns, C <sub>L</sub> = 50		34 - 15 - 15 - 15 - 15 - 15 - 15 - 15 - 1	- 12-		
CHARACTERISTICS	SYMBOL	V <sub>cc</sub> (V)		NT TEMPE		<u></u> ) - °C 	
CHANACTERISTICS	STINDOL	(V)	MIN	MAX.	MIN.	MAX.	1
Propagation Delays_ CP, (CP) to Q, Q	t <sub>PLH</sub> t <sub>PHL</sub>	5*	2.7	9.4	2.6	10.3	ns
S, R, to Q, Q	трін трні	5	3.2	11.1	3.1	12.2	ns
Power Dissipation Capacitance	CPD§	·	56	Гур.	56	Тур.	pF
Input Capacitance	Ci			10	_	10	pF

\*5 V: min. is @ 5.5 V max. is @ 4.5 V  $\label{eq:product} \ensuremath{\S{C_{PD}}}\xspace{1.5mu} \ensuremath{\mathsf{s}}\xspace{1.5mu} \ensuremath{\mathsf{c}}\xspace{1.5mu} \ensuremath{\mathsf{s}}\xspace{1.5mu} \$ 



Test circuit.

125

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